Application/Control No. Applicant(s)/Patent Under Reexamination 10/656,142 SEKIKAWA ET AL. Notic of References Cited Examiner Art Unit Page 1 of 1 H.Jey Tsai 2812 **U.S. PATENT DOCUMENTS Document Number** Date Name Country Code-Number-Kind Code MM-YYYY Classification Α US-6,069,036 05-2000 Kim, Jae-Kap 438/238 В US-US-С D US-US-Æ, F US-G US-US-Н 1 US-US-US-Κ US-L М US-**FOREIGN PATENT DOCUMENTS** Document Number Date Country Country Code-Number-Kind Code Name MM-YYYY Classification Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ Ŵ

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